

Intrinsic Gettering in Silicon

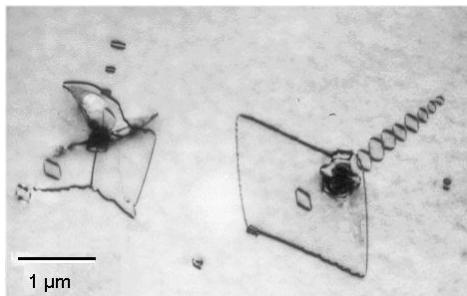
The Idea

The technical use of the term "gettering" (derived from "getting") goes back to the good old time of vacuum tubes that enabled early electronics, in particular radio and TV. Parts of the inside of the glass tubes was coated with a "getter" (typically titanium) that "got" the remaining gas molecules by reacting with them, thus improving and maintaining vacuum conditions.

- Just for the hell of it, here are two old electron tubes with their getter layer. The big one is from around 1930, I guess, the smaller one might date to 1950/60. A decent radio needed 5 - 10 of those things; your i-phone would need about 100.000.000.000 or so (plus a major power plant to supply the needed energy). Aren't you glad we invented integrated circuits?



- While this kind of gettering is still used in vacuum technology, **gettering in silicon** is somewhat different. The idea is to "get" or getter itinerant metal atoms that are still present in the silicon crystal - albeit at very low concentrations. We want to imprison these metal atoms somewhere in the bulk of the crystal and thus keep them from wreaking havoc in the active layer close to the surface that contains the transistors or other electronic components. All one needs to know about the "wreaking havoc" part is that many metals (in particular our friend, the iron) are able to kill transistors at concentrations in the ppqt region, a concentration a billion times smaller than what chemists would call "high purity".
- What could we use as "getter"? One might put some titanium, or some other highly reactive stuff on the Si wafer backside, hoping that they catch or getter impurity atoms as soon as they happen to come by. Backside or "external" gettering is actually done to some extent, especially in solar cell technology, but in different ways.
- Internal or intrinsic gettering, however, is far more effective. The getter in this case consists of intrinsic defects that are distributed all over the bulk of the silicon wafer - but not in the first (10 - 20) μm below the surface. This is important because these getter defects would definitely kill transistors and thus must be avoided in the active region.
- What are those intrinsic defects? They are **oxygen precipitates** plus, perhaps, some dislocations created by these precipitates in their immediate environment. Here is what this might look like:



SiO₂ precipitates plus some dislocations as seen in [TEM](#).

You might have seen this picture [before](#).

Source: My friends H. Strunk and B.O. Kolbesen

- Defects like this generally attract point defects and incorporate them into their structure, effectively immobilizing them.

We now need to answer two *questions*:

- How do we make those defects? Keeping in mind that we need just the [right size](#) - neither too small nor too big.
- How can we produce a "**denuded zone**", a region free of those defects below the surface of the wafer?

If you made it through the [nucleation modules](#) and the [Ostwald ripening module](#), you can come up with the [answers](#):

- If you want to make oxygen precipitates, you must supply oxygen in supersaturation. If you want to make these precipitates in a certain size and density, you must carefully determine the proper combination of initial oxygen concentration in your crystal / wafer and the temperature treatments needed.
- If you want to avoid oxygen precipitation in surface near regions, you must decrease the oxygen concentration in these regions to values low enough to prevent nucleation.

This is clear enough. Armed with the phase diagram of silicon - oxygen, the diffusivity of oxygen (and some other entities) in silicon, and some idea about nucleation, a material [scientist](#) could now calculate the optimal strategy and tell you what kind of crystal you need to buy and what you must do with it.

- Ha ha! You, being the [smith engineer](#), do not live in the ideal world of science but in the real world, where money is of importance. You know a few things about making microchips that can be sold because they are not prohibitively expensive:

- You cannot order Si wafers with any oxygen concentration but must go with what is available at reasonable cost. That means you must live with oxygen concentrations somewhere in the 10 ppm range.
- You cannot go for some very special temperature treatment just for making oxygen precipitates because making transistors already defines very special temperature treatments anyway, and these you simply have to do. The best thing would be if those treatments would, as a beneficial side effect, produce the required oxygen precipitates, too.
- If anything comes on top of that, it must be affordable. You cannot, for example, afford very long tempering processes if you need to process a couple of thousand wafers every day.

Doing It

Now we are talking about extensive and expensive R&D efforts that will come up with a process that is compatible with these requirements and then is rather specific to the company that developed it. Since intrinsic gettering is important, it comes as no surprise that specific data are quite confidential.

Some general data are known, however, and I will give you a taste treat of what is going on in what follows.

1. Oxygen concentration.

You specify, for example, an oxygen concentration of $8.5 \cdot 10^{17} \text{ cm}^{-3} \pm$ some tolerance to your wafer supplier. Larger tolerance bandwidths make the wafers cheaper.

2. Denuded zone formation

Nothing helps. You must, as a first step, keep your wafers at some rather high temperature (e.g. **1100 °C**; 2012 °F) for some time (e.g. 10 h). Oxygen atoms than are mobile and their [diffusion length](#) for these data is roughly around 10 μm. If you provide some environment that carries off any oxygen atoms that happens to come to the surface, the oxygen concentration close to the surface will decrease to about $3 \cdot 10^{17} \text{ cm}^{-3}$. This is not unlike the de-carburization of steel that might happen when you forge at high temperatures.

If you increase the temperature, this will happen faster. Since time is money you tend to do that. However, your wafers are inside a ultrapure quartz tube and above **1100 °C** this (expensive) tube starts to soften and its lifetime

decreases. In other words: you must find a compromise.

3. Nucleation of oxygen precipitates

You have a rather perfect crystal with supersaturated oxygen, so basic [homogeneous nucleation theory](#) should apply. Well, yes, except that carbon, always present in concentrations around 1 ppm, might induce heterogenous nucleation to some extent.

Whatever, if you want serious nucleation you should use relatively low temperatures because that makes the critical radii smaller. Since you still need some oxygen movement and don't want to wait forever, you can't go to extremely low temperatures.

Several hours around **750 °C** (1382 °F) might be the thing to do.

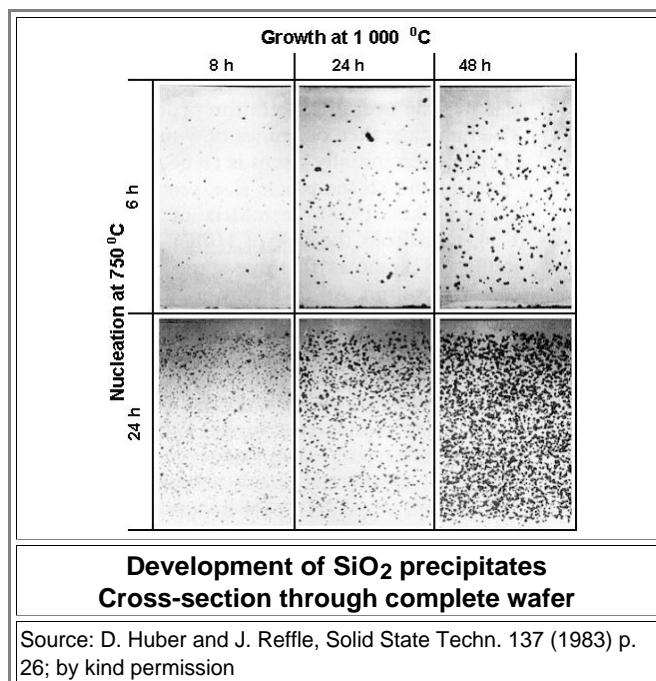
4. Growth of oxygen precipitates

The small oxygen precipitates produced during the nucleation process are too small for efficient gettering.

Growing them to useful sizes at the low nucleation temperature takes far too long, so you now induce a growth phase by going to a high temperature.

A few hours around **1000 °C** (1832 °F) might be the thing to do.

Now you are done. You employ what is known as the "High-Low-High" process to produce the precipitate structure you need. Below are a few examples of what you might get, taken from the well-known paper of D. Huber and J. Reffle. **Diethart Huber** (together with **Werner Zulehner**) worked for Wacker, one of the few big Si crystal makers in R&D. They are not only well known to me but to about everybody else in semiconductor science in Europe (and beyond) because, besides being well-known silicon scientists, they supplied us poor university guys with all kinds of silicon samples "just so". Thank you, Diethart and Werner!



- The initial oxygen concentration was **$8.15 \cdot 10^{17} \text{ cm}^{-3}$** . The precipitates were rendered visible by [defect etching](#). Shown are just a few out of many pictures for various parameters. Note the denuded zone obtained by a first outdiffusion treatment at **1100 °C** (2012 °F) for 10 hours.
- The picture makes clear that details matter a lot. The process you use for your product might thus be quite different from what I show here - and it's your secret!

The Parallels to Wootz Blade Making

- The parallels to the making of a wootz sword are obvious, I hope.
- What you start with is extremely important. Not all wootz steel cakes are the same. You need some with a [striated distribution](#) of carbides or carbide formers; just having 'hypereutectoid steel will not be good enough. Nobody knows how that would turn into a detailed specification list but we can be rather sure that it would contain a number of specific entries.
- You need to forge it in such a way that the striated distribution of carbides or carbide formers (like vanadium (V) or titanium (Ti)) is conserved in your blade.
- The heat treatments you need for forging should promote the nucleation of carbides in the striated pattern and their growth to rather large sizes. At the same time you must prevent at all costs the formation of cementite shells around the grains of pearlite, the natural process that usually takes place.

- If the temperature cycles you use for forging are not sufficient for achieving these goals, you must treat the finished blade in a way that promotes [Ostwald ripening](#). You might use temperature cycling for this, carefully selecting the right temperatures and temper times or doing this (and measuring the temperature and time by guessing).

Now you will have produced a blade that will exhibit the typical wootz pattern after polishing and etching.

- If you want to go beyond this and produce a wootz blade that

- shows a structure like "Muhammed's latter" in the pattern
- is particularly hard, flexible, and doesn't break if bent to a semicircle, you use secrets that we only can guess at.